


<b>Search Notes</b>  	<b>Application/Control No.</b>  10670894	<b>Applicant(s)/Patent Under Reexamination</b>  SEN ET AL.
	<b>Examiner</b>  Hung, Yubin	<b>Art Unit</b>  2624

SEARCHED			
Class	Subclass	Date	Examiner
382	103,107,209,240,248,278,281,302	7/7/08	YH
348	154,155,398.1,403.1,407.1	7/7/08	YH
375	240.19	7/7/08	YH

SEARCH NOTES			
Search Notes		Date	Examiner
EAST text search (USPGPUB, USPAT, EPO, JPO, DERWENT, IBM-TDB)		7/8/08	YH
ACM		7/8/08	YH
SPIE		7/8/08	YH
IEEE Xplore		7/8/08	YH
Inventor/assignee search (EAST, eDAN)		7/7/08	YH

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
382	103, 107, 240, 248, 281	7/7/08	YH
348	398.1	7/7/08	YH
375	240.19	7/7/08	YH